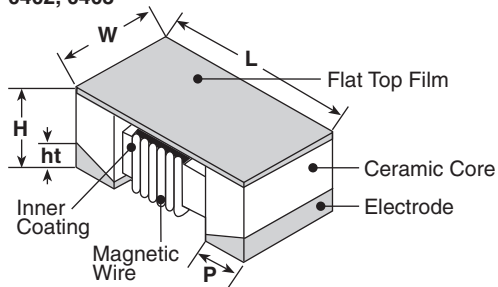


features

- Low DC resistance and high allowable DC current
- Low profile style 0.027 inches (0.7mm) typical
- Suitable for reflow soldering
- Marking: Black body color with no marking
- Products with lead-free terminations meet EU RoHS requirements

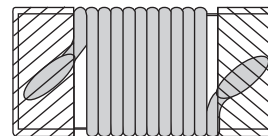
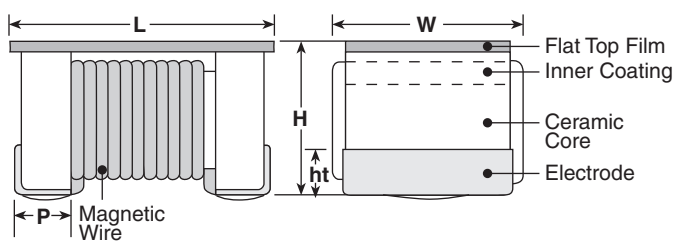
dimensions and construction

0402, 0403



Size Code	Dimensions inches (mm)				
	L	W	H	Ht	P
0402	.039±.004 (1.0±0.1)	.020±.004 (0.5±0.1)	.022±.004 (0.55±0.1)	.006±.004 (0.15±0.1)	.008±.004 (0.2±0.1)
UNDER DEVELOPMENT 0403	.039±.004 (1.0±0.1)	.03±.008 (0.75±0.2)	.031±.004 (0.8±0.1)	.006±.004 (0.15±0.1)	.008±.004 (0.2±0.1)
0603	.063±.004 (1.6±0.1)	.041±.008 (1.05±0.2)	.028±.004 (0.7±0.1)	.008±.006 (0.2±0.15)	.015±.004 (0.37±0.1)

0603



ordering information

New Part #	KQC	0603	T	TE	12N	J
	Type	Size Code	Termination Material	Packaging	Nominal Resistance	Tolerance
		0402 0403 0603	T: Sn	TP: 2mm pitch paper (0402: 10,000 pieces/reel) TE: 4mm pitch embossed plastic (0403, 0603: 2,000 pieces/reel) TD: 4mm pitch paper (0402: 2,000 pieces/reel)		B: ±0.1nH C: ±0.2nH G: ±2% J: ±5%

For further information on packaging, please refer to Appendix A.

applications and ratings

Part Designation	Nominal Inductance (nH)	L Measuring Frequency	Inductance Tolerance	Q Quality Factor Minimum	Q Measuring Frequency (MHz)	Self Resonant Frequency Minimum (GHz)	DC Resistance Maximum (Ω)	Allowable DC Current Maximum (A)		
KQC0402T**1N4*	1.4	250	B: ± 0.1 nH%	25	250	11.0	0.019	1.40		
KQC0402T**1N5*	1.5					10.0				
KQC0402T**1N6*	1.6					9.6				
KQC0402T**1N7*	1.7					8.5				
KQC0402T**2N5*	2.5					8.0				
KQC0402T**2N7*	2.7					7.2				
KQC0402T**3N0*	3.0		C: ± 0.2 nH	29		6.6	0.028	1.20		
KQC0402T**3N3*	3.3					7.3				
KQC0402T**3N9*	3.9					7.0				
KQC0402T**4N3*	4.3					6.6				
KQC0402T**4N7*	4.7					5.6				
KQC0402T**6N2*	6.2					5.6			0.045	0.90
KQC0403TTE0N8*	0.8	250	C: ± 0.2 nH	26	250	13.8	0.010	2.30		
KQC0403TTE2N0*	2.0					10.7	0.017	2.00		
KQC0403TTE2N2*	2.2					8.5	0.024	1.70		
KQC0403TTE3N6*	3.6		6.7							
KQC0403TTE3N9*	3.9		6.6							
KQC0403TTE4N3*	4.3		33	6.4		0.026	1.60			
KQC0403TTE5N6*	5.6			6.6		0.036	1.50			
KQC0403TTE6N6*	6.6			4.8						
KQC0403TTE8N5*	8.5		5.5	0.055				1.20		
KQC0403TTE9N1*	9.1		5.2							
KQC0403TTE12N*	12		3.4			0.076	1.00			
KQC0403TTE16N*	16		33	2.9		0.105	0.80			
KQC0403TTE21N*	21			2.7		0.164	0.60			
KQC0603TTE1N2*	1.2			250		J: $\pm 5\%$	35	250	6.0	0.020
KQC0603TTE2N7*	2.7		6.0						0.025	2.00
KQC0603TTE4N7*	4.7	5.5	0.035		1.80					
KQC0603TTE5N6*	5.6									
KQC0603TTE7N5*	7.5									
KQC0603TTE8N2*	8.2	4.0	0.045		1.50					
KQC0603TTE10N*	10									
KQC0603TTE12N*	12									
KQC0603TTE15N*	15	3.0	0.065		1.25					
KQC0603TTE18N*	18									
KQC0603TTE22N*	22									
KQC0603TTE27N*	27	2.5	0.090		1.20					
			0.100		1.10					
			0.120	1.00						

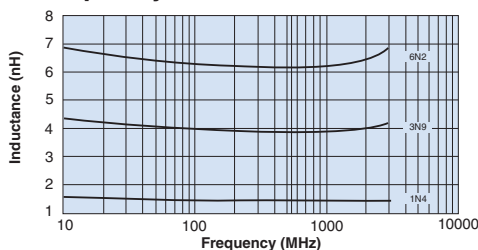
UNDER DEVELOPMENT

Inductors

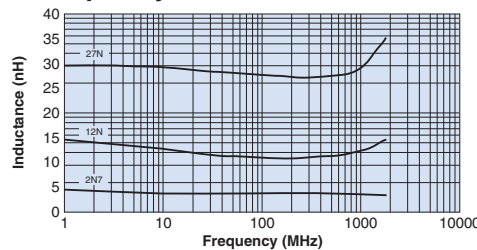
* Add tolerance character (B, C, J, G)
** Add packaging character (TD, TP)

environmental applications

L-Frequency Characteristics - 0402



L-Frequency Characteristics - 0603

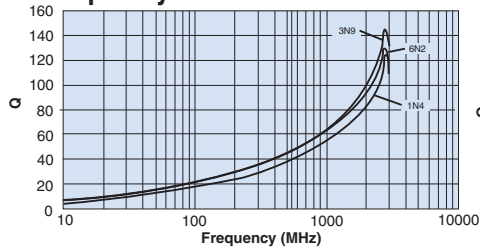


Specifications given herein may be changed at any time without prior notice. Please confirm technical specifications before you order and/or use.

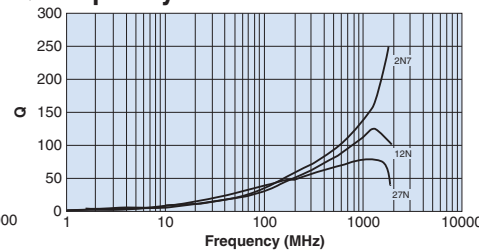
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environmental applications (continued)

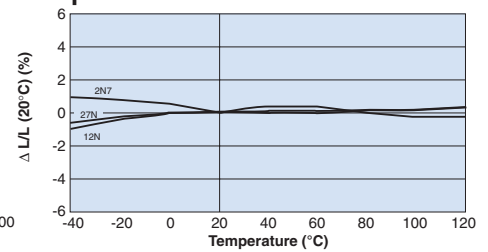
G-Frequency Characteristics - 0402



Q-Frequency Characteristics - 0603



Temperature Characteristics



Performance Characteristics

Parameter	Requirements Maximum Limit	ΔL/L Typical	Test Method
Resistance to Soldering Heat	No significant abnormality in appearance Δ L/L: ±5%, Δ Q/Q: ±10%	Δ L/L: ±1.2% Δ Q/Q: ±2.7%	260°C ± 5°C, 10s ± 1s
Rapid Change of Temperature	No significant abnormality in appearance Δ L/L: ±5%, Δ Q/Q: ±10%	Δ L/L: ±1.9% Δ Q/Q: ±3.9%	-40°C (30min.)/ +125°C (30min.) 100 cycles
Low Temperature Exposure	No significant abnormality in appearance Δ L/L: ±5%, Δ Q/Q: ±10%	Δ L/L: ±2.0% Δ Q/Q: ±4.1%	-40°C ± 2°C, 1000h
High Temperature Exposure	No significant abnormality in appearance Δ L/L: ±5%, Δ Q/Q: ±10%	Δ L/L: ±1.8% Δ Q/Q: ±3.3%	125°C ± 2°C, 1000h
Moisture Exposure	No significant abnormality in appearance Δ L/L: ±5%, Δ Q/Q: ±10%	Δ L/L: ±1.7% Δ Q/Q: ±3.3%	40°C ± 2°C, 90%~95%RH, 1000h
Resistance to Solvent	No damage and marking shall remain legible	—	Accordance with MIL-STD 202F Method 215